

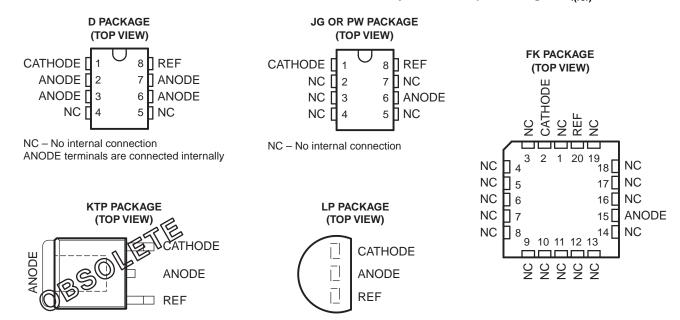
PRECISION PROGRAMMABLE REFERENCE

Check for Samples: TL1431

FEATURES

- 0.4% Initial Voltage Tolerance
- 0.2-Ω Typical Output Impedance
- Fast Turnon...500 ns

- Sink Current Capability...1 mA to 100 mA
- Low Reference Current (REF)
- Adjustable Output Voltage...V_{I(ref)} to 36 V



DESCRIPTION/ORDERING INFORMATION

The TL1431 is a precision programmable reference with specified thermal stability over automotive, commercial, and military temperature ranges. The output voltage can be set to any value between $V_{I(ref)}$ (approximately 2.5 V) and 36 V with two external resistors (see Figure 16). This device has a typical output impedance of 0.2 Ω . Active output circuitry provides a very sharp turnon characteristic, making the device an excellent replacement for Zener diodes and other types of references in applications such as onboard regulation, adjustable power supplies, and switching power supplies.

The TL1431C is characterized for operation over the commercial temperature range of 0°C to 70°C. The TL1431Q is characterized for operation over the full automotive temperature range of –40°C to 125°C. The TL1431M is characterized for operation over the full military temperature range of –55°C to 125°C.



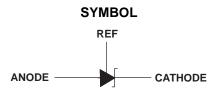
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



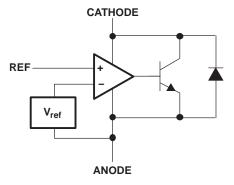
ORDERING INFORMATION(1)

T _A	PACI	KAGE ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	PowerFLEX™ – KTP	Reel of 3000	TL1431CKTPR	OBSOLETE	
	COIC D	Tube of 75	TL1431CD	44040	
	SOIC – D	Reel of 2500	TL1431CDR	1431C	
0°C to 70°C		Bulk of 1000	TL1431CLP		
0°C to 70°C	TO-226 / TO-92 – LP	Reel of 2000	TL1431CLPR	TL1431C	
		Ammo of 2000	TL1431CLPME3		
	TCCOD DW	Tube of 150	TL1431CPW	T4 404	
	TSSOP – PW	Reel of 2000	TL1431CPWR	T1431	
	SOIC D	Tube of 75	TL1431QD	TI 44040D	
-40°C to 125°C	SOIC – D	Reel of 2500	TL1431QDR	TL1431QD	
-40°C to 125°C	TCCOD DW	Tube of 150	TL1431QPW	T4 424 ODW	
	TSSOP – PW	Reel of 2000	TL1431QPWR	T1431QPW	
5500 to 40500	CDIP – JG	Tube of 50	TL1431MJG	TL1431MJG	
–55°C to 125°C	LCCC – FK	Tube of 55	TL1431MFK	TL1431MFK	

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.



FUNCTIONAL BLOCK DIAGRAM





CATHODE Ω 008 **800** Ω 20 pF REF 150 Ω 3.28 $k\Omega$ 4 $k\Omega$ 10 $k\Omega$ 20 pF 7.2 $k\Omega$ 2.4 kΩ ≤

1 $\mathbf{k}\Omega$

EQUIVALENT SCHEMATIC

- All component values are nominal.
- Pin numbers shown are for the D package.

Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

 800Ω

			MIN	MAX	UNIT	
V _{KA}	Cathode voltage (2)			37	V	
I _{KA}	Continuous cathode current range		-100	150	mA	
I _{I(ref)}	Reference input current range		-0.05	10	mA	
		D package		97		
θ_{JA}	Package thermal impedance (3) (4)	LP package		140	°C/W	
		PW package		149		
0	Package thermal impedance ⁽⁵⁾ (6)	FK package		5.61	00044	
θ_{JC}	Package thermal impedance (** (**)	JG package		14.5	°C/W	
TJ	Operating virtual junction temperature			150	°C	
	Lead temperature	1,6 mm (1/16 in) from case for 10 s		260	°C	
T _{stg}	Storage temperature range	-65	150	°C		

- Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- All voltage values are with respect to ANODE, unless otherwise noted.
- Maximum power dissipation is a function of $T_{J(max)}$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_{J(max)} T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can affect reliability.
- The package thermal impedance is calculated in accordance with JESD 51-7.
- Maximum power dissipation is a function of $T_{J(max)}$, θ_{JC} , and T_{C} . The maximum allowable power dissipation at any allowable case temperature is $P_{D} = (T_{J(max)} T_{C})/\theta_{JC}$. Operating at the absolute maximum T_{J} of 150°C can affect reliability.

Product Folder Links: TL1431

The package thermal impedance is calculated in accordance with MIL-STD-883.



Recommended Operating Conditions

			MIN	MAX	UNIT
V_{KA}	Cathode voltage		$V_{I(ref)}$	36	V
I _{KA}	Cathode current		1	100	mA
		TL1431C	0	70	
T _A	Operating free-air temperature	TL1431Q	-40	125	°C
		TL1431M	- 55	125	

Electrical Characteristics

at specified free-air temperature, $I_{KA} = 10$ mA (unless otherwise noted)

	DADAMETED	TEST CONDITIONS	- (1)	TEST	Т	L1431C		LINUT	
	PARAMETER	TEST CONDITIONS	T _A ⁽¹⁾	CIRCUIT	MIN	TYP	MAX	UNIT	
.,	Defenses involved	M M	25°C	Figure 4	2490	2500	2510	\/	
V _{I(ref)}	Reference input voltage	$V_{KA} = V_{I(ref)}$	Full range	Figure 1	2480		2520	mV	
V _{I(dev)}	Deviation of reference input voltage over full temperature range (2)	$V_{KA} = V_{I(ref)}$	Full range	Figure 1		4	20	mV	
$\frac{\Delta V_{\text{I(ref)}}}{\Delta V_{\text{KA}}}$	Ratio of change in reference input voltage to the change in cathode voltage	$\Delta V_{KA} = 3 \text{ V to } 36 \text{ V}$	Full range	Figure 2		-1.1	-2	mV/V	
	Potoronoo input ourront	R1 = 10 kΩ, R2 = ∞	25°C	Figure 2		1.5	2.5	μA	
I _{I(ref)}	Reference input current	K1 = 10 K12, K2 = ~	Full range	Figure 2			3	μΛ	
I _{I(dev)}	Deviation of reference input current over full temperature range ⁽²⁾	R1 = 10 kΩ, R2 = ∞	Full range	Figure 2		0.2	1.2	μΑ	
I _{min}	Minimum cathode current for regulation	$V_{KA} = V_{I(ref)}$	25°C	Figure 1		0.45	1	mA	
	Off-state cathode current	V - 26 V V - 0	25°C	Figure 3		0.18	0.5	μA	
l _{off}	On-state cathode current	$V_{KA} = 36 \text{ V}, V_{I(ref)} = 0$	Full range	rigule 3			2	μΛ	
z _{KA}	Output impedance (3)	$V_{KA} = V_{I(ref)}$, f \leq 1 kHz, $I_{KA} = 1$ mA to 100 mA	25°C	Figure 1		0.2	0.4	Ω	

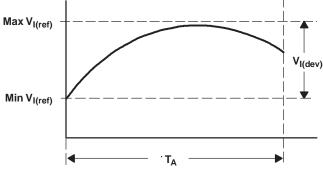
Full range is 0°C to 70°C for C-suffix devices.

The deviation parameters $V_{I(dev)}$ and $I_{I(dev)}$ are defined as the differences between the maximum and minimum values obtained over the rated temperature range. The average full-range temperature coefficient of the reference input voltage $\alpha_{VI(ref)}$ is defined as:

$$\left| \alpha_{\text{VI(ref)}} \right| \left(\frac{\text{ppm}}{^{\circ}\text{C}} \right) = \frac{\left(\frac{\text{VI(dev)}}{\text{VI(ref)} \text{ at } 25^{\circ}\text{C}} \right) \times 10^{6}}{\text{T}_{\text{A}}}$$

where:

 ΔT_A is the rated operating temperature range of the device.



 $\alpha_{VI(ref)}$ is positive or negative, depending on whether minimum $V_{I(ref)}$ or maximum $V_{I(ref)}$, respectively, occurs at the lower temperature. The output impedance is defined as: $|Z_{_{KA}}| = \frac{\Delta V_{_{KA}}}{\Delta I_{_{KA}}}$ When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by: $|z'| = \frac{\Delta V}{\Delta I}$, which is approximately equal to $|z_{KA}| \left(1 + \frac{R1}{R2}\right)$.



Electrical Characteristics

at specified free-air temperature, $I_{KA} = 10$ mA (unless otherwise noted)

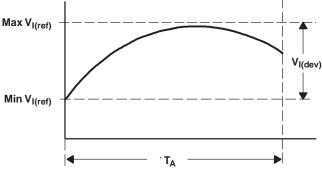
	PARAMETER	TEST CONDITIONS	T _A (1)	TEST	Т	L1431Q		Т	L1431M		UNIT
	PARAMETER	TEST CONDITIONS	IA (''	CIRCUIT	MIN	TYP	MAX	MIN	TYP	MAX	UNII
			25°C		2490	2500	2510	2475	2500	2540	
V _{I(ref)}	Reference input voltage	$V_{KA} = V_{I(ref)}$	Full range	Figure 1	2470		2530	2460		2550	mV
$V_{I(dev)}$	Deviation of reference input voltage over full temperature range (2)	$V_{KA} = V_{I(ref)}$	Full range	Figure 1		17	55		17	55 ⁽³⁾	mV
$\frac{\Delta V_{\text{l(ref)}}}{\Delta V_{\text{KA}}}$	Ratio of change in reference input voltage to the change in cathode voltage	$\Delta V_{KA} = 3 \text{ V to } 36 \text{ V}$	Full range	Figure 2		-1.1	-2		-1.1	-2	mV/V
			25°C			1.5	2.5		1.5	2.5	
I _{I(ref)}	Reference input current	R1 = 10 kΩ, R2 = ∞	Full range	Figure 2			4			5	μA
I _{I(dev)}	Deviation of reference input current over full temperature range (2)	R1 = 10 kΩ, R2 = ∞	Full range	Figure 2		0.5	2		0.5	3(3)	μA
I _{min}	Minimum cathode current for regulation	V _{KA} = V _{I(ref)}	25°C	Figure 1		0.45	1		0.45	1	mA
	Off-state cathode		25°C			0.18	0.5		0.18	0.5	
I _{off}	current	$V_{KA} = 36 \text{ V}, V_{I(ref)} = 0$	Full range	Figure 3			2			2	μΑ
z _{KA}	Output impedance (4)	$V_{KA} = V_{I(ref)}$, $f \le 1 \text{ kHz}$, $I_{KA} = 1 \text{ mA to } 100 \text{ mA}$	25°C	Figure 1		0.2	0.4		0.2	0.4	Ω

Full range is -40°C to 125°C for Q-suffix devices and -55°C to 125°C for M-suffix devices.

The deviation parameters $V_{I(dev)}$ and $I_{I(dev)}$ are defined as the differences between the maximum and minimum values obtained over the rated temperature range. The average full-range temperature coefficient of the reference input voltage $\alpha_{VI(ref)}$ is defined as:

$$\left| \alpha_{\text{vi(ref)}} \right| \left(\frac{\text{ppm}}{^{\circ}\text{C}} \right) = \frac{\left(\frac{\text{V}_{\text{I(dev)}}}{\text{V}_{\text{I(ref)}} \text{ at 25}^{\circ}\text{C}} \right) \times 10^{6}}{\text{T}_{\text{A}}}$$

 $\Delta T_{\mbox{\scriptsize A}}$ is the rated operating temperature range of the device.



 $\alpha_{VI(ref)}$ is positive or negative, depending on whether minimum $V_{I(ref)}$ or maximum $V_{I(ref)}$, respectively, occurs at the lower temperature. On products compliant to MIL-PRF-38535, this parameter is not production tested. The output impedance is defined as: $|Z_{KA}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by: , which is approximately equal to $|z_{\text{KA}}| \left(1 + \frac{R1}{R2}\right)$



PARAMETER MEASUREMENT INFORMATION

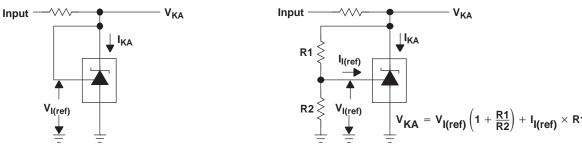


Figure 1. Test Circuit for $V_{(KA)} = V_{ref}$

Figure 2. Test Circuit for $V_{(KA)} > V_{ref}$

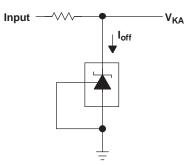


Figure 3. Test Circuit for Ioff

TYPICAL CHARACTERISTICS

Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

Table of Graphs

GRAPH	FIGURE
Reference voltage vs Free-air temperature	Figure 4
Reference current vs Fire-air temperature	Figure 5
Cathode current vs Cathode voltage	Figure 6, Figure 7
Off-state cathode current vs Free-air temperature	Figure 8
Ratio of delta reference voltage to delta cathode voltage vs Free-air temperature	Figure 9
Equivalent input-noise voltage vs Frequency	Figure 10
Equivalent input-noise voltage over a 10-second period	Figure 11
Small-signal voltage amplification vs Frequency	Figure 12
Reference impedance vs Frequency	Figure 13
Pulse response	Figure 14
Stability boundary conditions	Figure 15

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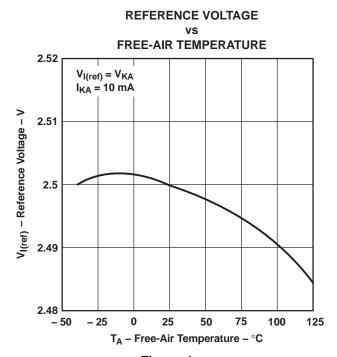
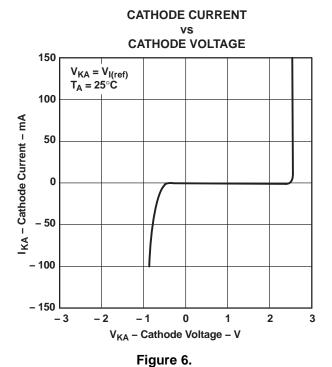


Figure 4.



REFERENCE CURRENT vs

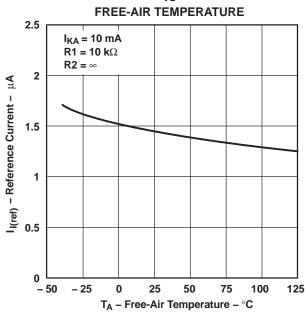
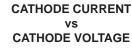


Figure 5.



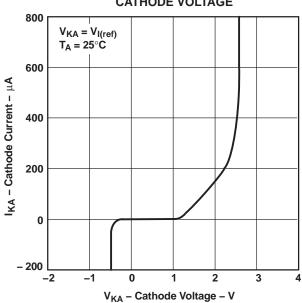
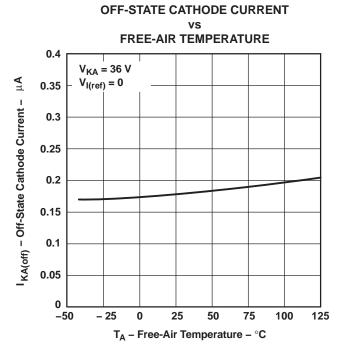


Figure 7.





RATIO OF DELTA REFERENCE VOLTAGE TO DELTA CATHODE VOLTAGE

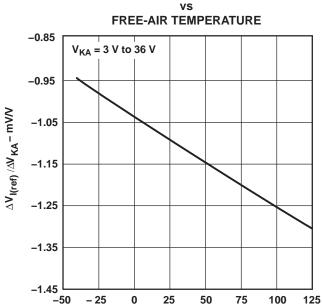
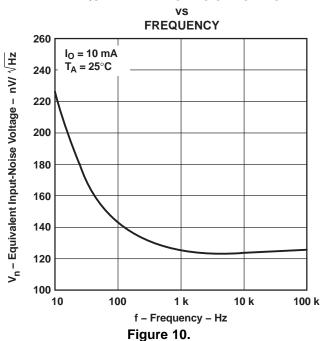


Figure 8.

Figure 9.

 T_A – Free-Air Temperature – $^{\circ}C$

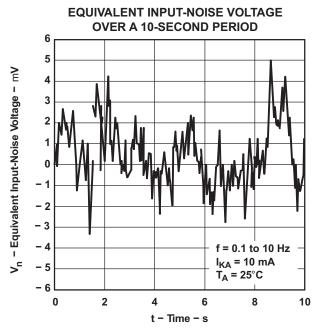
EQUIVALENT INPUT-NOISE VOLTAGE

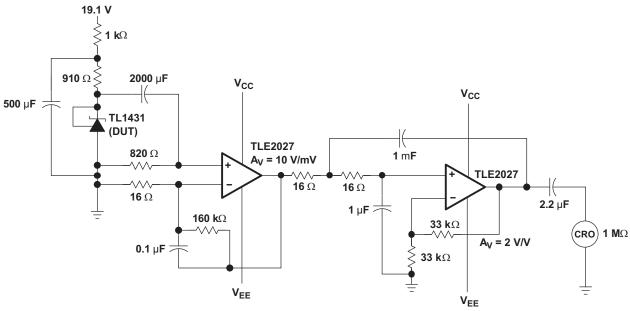


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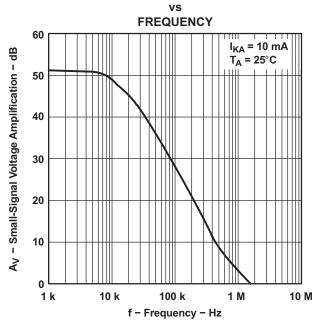


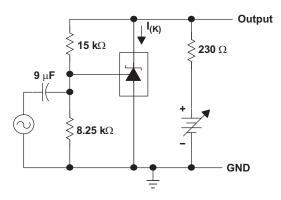
TEST CIRCUIT FOR 0.1-Hz TO 10-Hz EQUIVALENT INPUT-NOISE VOLTAGE

Figure 11.



SMALL-SIGNAL VOLTAGE AMPLIFICATION

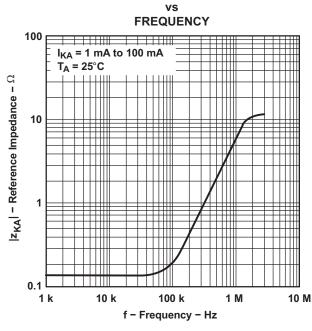


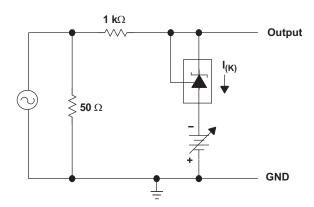


TEST CIRCUIT FOR VOLTAGE AMPLIFICATION

Figure 12.

REFERENCE IMPEDANCE

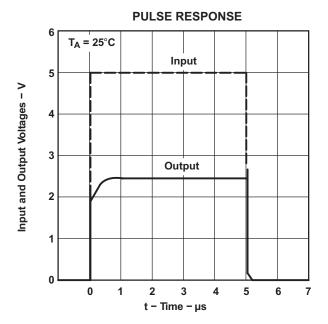




TEST CIRCUIT FOR REFERENCE IMPEDANCE

Figure 13.





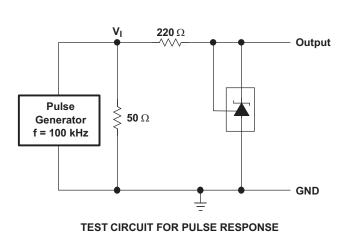
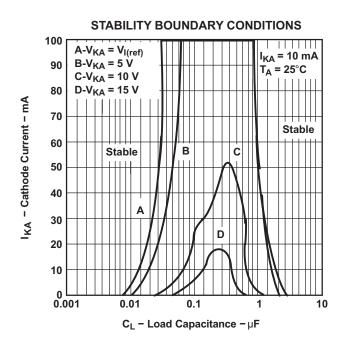
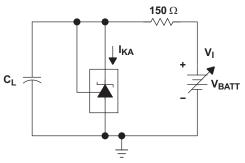
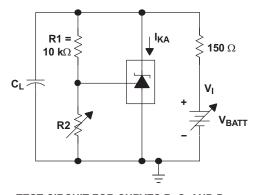


Figure 14.





TEST CIRCUIT FOR CURVE A



TEST CIRCUIT FOR CURVES B, C, AND D

A. The areas under the curves represent conditions that may cause the device to oscillate. For curves B, C, and D, R2, and V+ are adjusted to establish the initial V_{KA} and I_{KA} conditions, with $C_L = 0$. V_{BATT} and C_L then are adjusted to determine the ranges of stability.

Figure 15.

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APPLICATION INFORMATION

Table 1. Table of Application Circuits

APPLICATION	FIGURE
Shunt regulator	Figure 16
Single-supply comparator with temperature-compensated threshold	Figure 17
Precision high-current series regulator	Figure 18
Output control of a three-terminal fixed regulator	Figure 19
Higher-current shunt regulator	Figure 20
Crowbar	Figure 21
Precision 5-V, 1.5-A, 0.5% regulator	Figure 22
5-V precision regulator	Figure 23
PWM converter with 0.5% reference	Figure 24
Voltage monitor	Figure 25
Delay timer	Figure 26
Precision current limiter	Figure 27
Precision constant-current sink	Figure 28

A. R should provide cathode current ≥1 mA to the TL1431 at minimum V_(BATT).

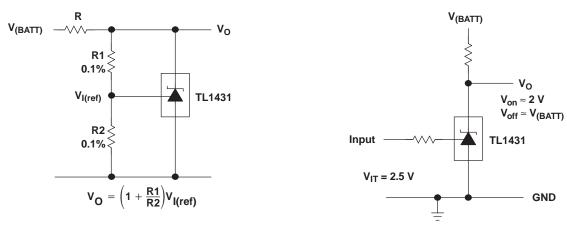
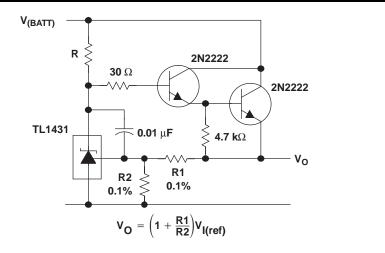


Figure 16. Shunt Regulator

Figure 17. Single-Supply Comparator With Temperature-Compensated Threshold

A. R should provide cathode current \geq 1 mA to the TL1431 at minimum $V_{(BATT)}$.





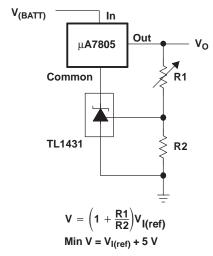


Figure 18. Precision High-Current Series Regulator

Figure 19. Output Control of a Three-Terminal Fixed Regulator

A. Refer to the stability boundary conditions in Figure 15 to determine allowable values for C.

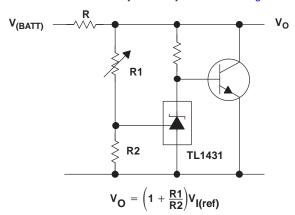


Figure 20. Higher-Current Shunt Regulator

A. R_b should provide cathode current ≥1 mA to the TL1431.

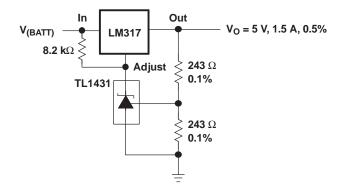


Figure 22. Precision 5-V, 1.5-A, 0.5% Regulator

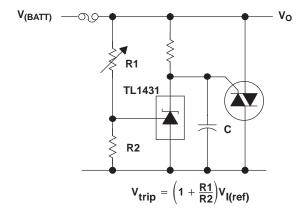


Figure 21. Crowbar

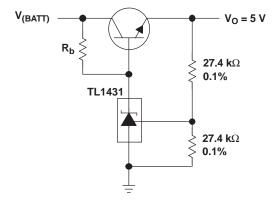


Figure 23. 5-V Precision Regulator



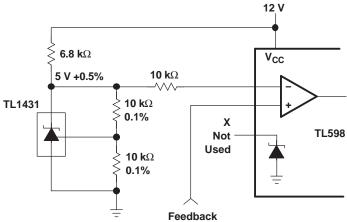


Figure 24. PWM Converter With 0.5% Reference

A. Select R3 and R4 to provide the desired LED intensity and cathode current ≥1 mA to the TL1431.

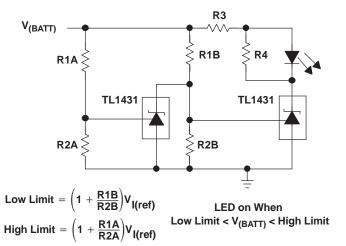


Figure 25. Voltage Monitor

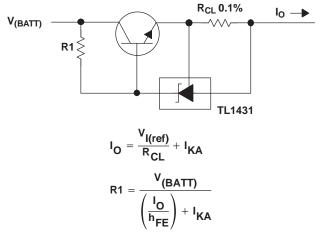


Figure 27. Precision Current Limiter

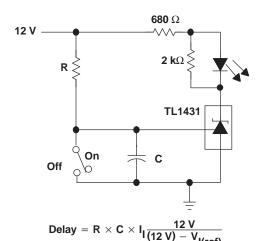


Figure 26. Delay Timer

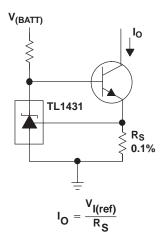


Figure 28. Precision Constant-Current Sink



REVISION HISTORY

CI	nanges from Revision October 2007 (N) to Revision M	Page
•	Added Ammo option to the LP package in the ORDERING INFORMATION table.	2





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9962001Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9962001Q2A TL1431MFKB	Samples
5962-9962001QPA	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9962001QPA TL1431M	Samples
TL1431CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CDE4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CDRE4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	1431C	Samples
TL1431CKTPR	OBSOLETI	E PFM	KTP	2		TBD	Call TI	Call TI	0 to 70		
TL1431CLP	ACTIVE	TO-92	LP	3	1000	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	0 to 70	TL1431C	Sample
TL1431CLPE3	ACTIVE	TO-92	LP	3	1000	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	0 to 70	TL1431C	Samples
TL1431CLPM	OBSOLETI	E TO-92	LP	3		TBD	Call TI	Call TI	0 to 70		
TL1431CLPME3	ACTIVE	TO-92	LP	3	2000	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	0 to 70	TL1431C	Sample
TL1431CLPR	ACTIVE	TO-92	LP	3	2000	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	0 to 70	TL1431C	Sample
TL1431CLPRE3	ACTIVE	TO-92	LP	3	2000	Pb-Free (RoHS)	CU SN	N / A for Pkg Type	0 to 70	TL1431C	Sample
TL1431CPW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	T1431	Samples
TL1431CPWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU CU SN	Level-1-260C-UNLIM	0 to 70	T1431	Samples





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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TL1431CPWRG4	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	T1431	Samples
TL1431MFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	TL1431MFK	Samples
TL1431MFKB	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9962001Q2A TL1431MFKB	Samples
TL1431MJG	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	TL1431MJG	Samples
TL1431MJGB	ACTIVE	CDIP	JG	8	1	TBD	A42	N / A for Pkg Type	-55 to 125	9962001QPA TL1431M	Samples
TL1431QD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	1431Q	Samples
TL1431QDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	1431Q	Samples
TL1431QDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	1431Q	Samples
TL1431QDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	1431Q	Samples
TL1431QLP	OBSOLETE	TO-92	LP	3		TBD	Call TI	Call TI	-40 to 125		
TL1431QLPR	OBSOLETE	TO-92	LP	3		TBD	Call TI	Call TI	-40 to 125		
TL1431QPWR	OBSOLETE	TSSOP	PW	8		TBD	Call TI	Call TI	-40 to 125	1431Q	
TL1431QPWRG4	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	1431Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

PACKAGE OPTION ADDENDUM



10-Jun-2014

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight

in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF TL1431, TL1431M:

Catalog: TL1431

Automotive: TL1431-Q1, TL1431-Q1

● Enhanced Product: TL1431-EP, TL1431-EP

Military: TL1431M

Space: TL1431-SP, TL1431-SP

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product



PACKAGE OPTION ADDENDUM

TEXAS INSTRUMENTS

10-Jun-2014

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
		Dimension designed to accommodate the component length
		Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ľ	P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

All difficultions are florifinal	ill difference are normal													
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant		
TL1431CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1		
TL1431CPWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1		
TL1431QDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1		

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TL1431CDR	SOIC	D	8	2500	340.5	338.1	20.6
TL1431CPWR	TSSOP	PW	8	2000	367.0	367.0	35.0
TL1431QDR	SOIC	D	8	2500	340.5	338.1	20.6

JG (R-GDIP-T8)

CERAMIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP1-T8

FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



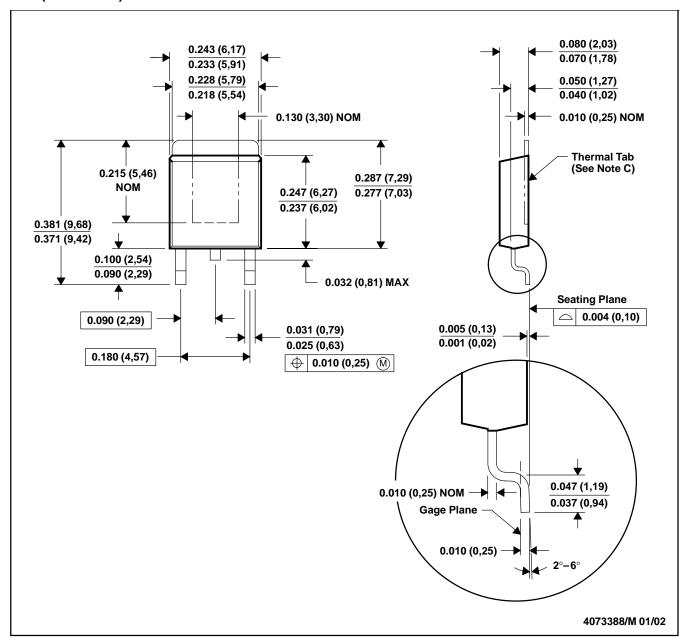
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



KTP (R-PSFM-G2)

PowerFLEX™ PLASTIC FLANGE-MOUNT PACKAGE



- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. The center lead is in electrical contact with the thermal tab.
 - D. Dimensions do not include mold protrusions, not to exceed 0.006 (0,15).
 - E. Falls within JEDEC TO-252 variation AC.

PowerFLEX is a trademark of Texas Instruments.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.



D (R-PDSO-G8)

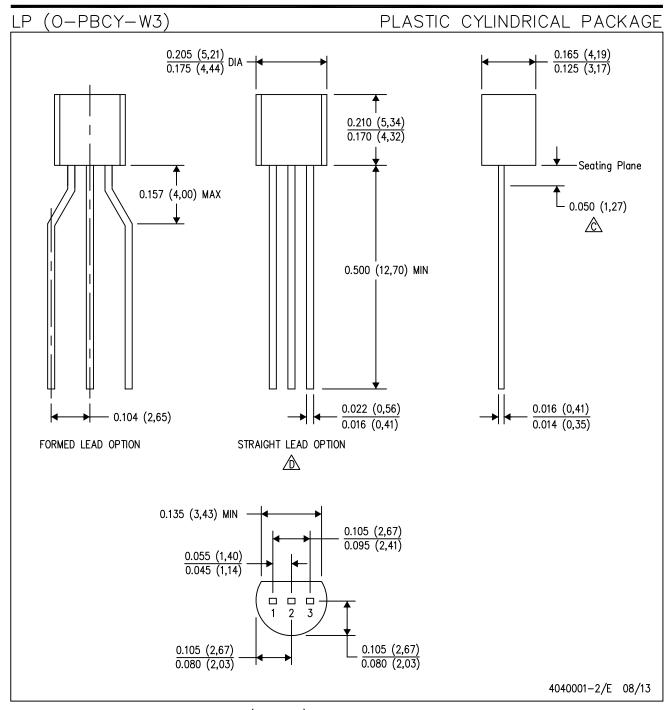
PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

Lead dimensions are not controlled within this area.

Falls within JEDEC TO−226 Variation AA (TO−226 replaces TO−92).

E. Shipping Method:

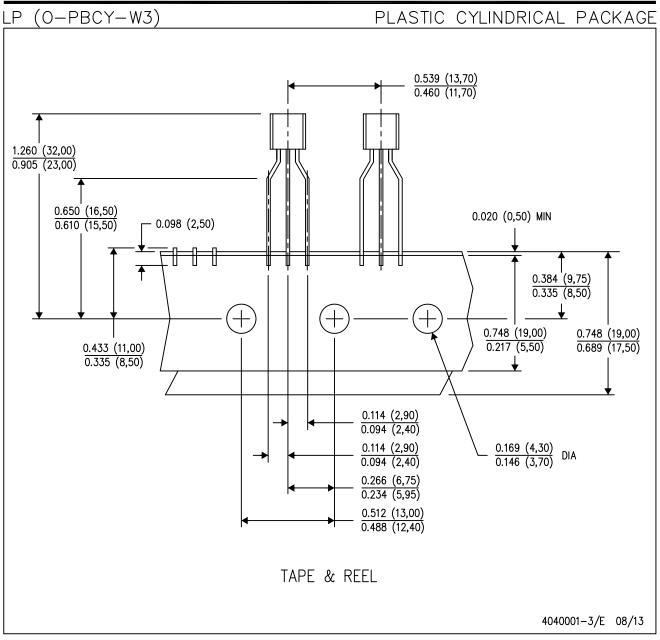
Straight lead option available in bulk pack only.

Formed lead option available in tape & reel or ammo pack.

Specific products can be offered in limited combinations of shipping mediums and lead options.

Consult product folder for more information on available options.



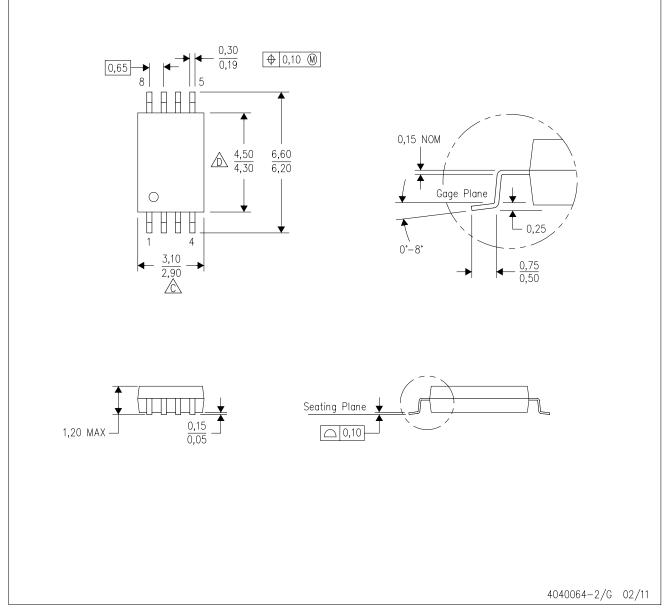


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Tape and Reel information for the Formed Lead Option package.

PW (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



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